

1/4W, 0805, Low Resistance Chip Resistor (Lead / Halogen Free)

1. Scope

This specification applies to 2.0mm x 1.25mm size 1/4W, fixed metal film chip resistors rectangular type for use in electronic equipment.

2. Type Designation

Where (1) Series No.

- (2) Temperature coefficient of resistance (T.C.R.) refer to paragraph 4-1
- (3) Resistance value: refer to paragraph 4-1 For example— Three digits of number $(0.1 \le R)$ $R10 = 0.1\Omega$ $1R0 = 1.0\Omega$ Four digits of number $(R < 0.1\Omega)$ $R022 = 0.022\Omega$ The "R" shall be used as a decimal point.
- (4) Resistance tolerance: refer to paragraph 4-1.

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3. Construction and Physical Dimensions

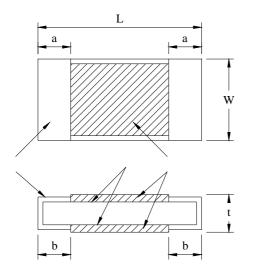


Figure 1-1. Double sides structure ($< 0.075\Omega$)

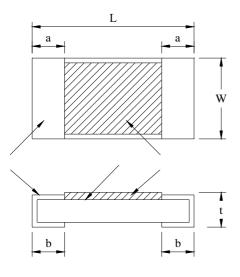


Figure 1-2. Single side structure ($\geq 0.075\Omega$)

Code Letter	Dimensions (mm)			
	Double sides Structure	Single side Structure		
L	2.00 ± 0.20	2.00 ± 0.20		
W	1.25 ± 0.20	1.25 ± 0.20		
t	0.50 ± 0.10	0.40 ± 0.10		
а	0.40 ± 0.20	0.40 ± 0.20		
b	0.40 ± 0.20	0.40 ± 0.20		

Note :

Nickel alloy film
plating
Sn 100% (Lead free)
Epoxy Resin coating
Alumina ceramic
cture 5mg (ref.)

Single side structure 4mg (ref.)



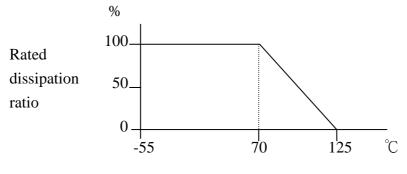
4. Ratings

4-1 Specification

Specification				
Power Rating*	1/4 W			
Resistance Value	$0.010\Omega \sim 0.039\Omega$	$0.043\Omega \sim 0.091\Omega$	$0.1\Omega \sim 10\Omega$	
Resistance Tolerance	$\pm 1\%$ (F), $\pm 2\%$ (G), $\pm 5\%$ (J)			
T.C.R (Temperature	0 + 250 mm /(T)	$0 \sim +200 \text{ppm/°C}(S)$	$0 \sim +100 \text{ppm/°C}(R)$	
Coefficient of Resistance)	0 ~ +350ppm/(T)	$0 \sim +350 \text{ppm/}^{\circ}\text{C}(\text{T})$	$0 \sim +200 \text{ppm/°C}(S)$	

Note*:

Power Rating is based on continuous full load operation at rated ambient temperature of 70° C. For resistors operated at ambient temperature in excess of 70° C, the maximum load shall be derated in accordance with the following curve.



Ambient temperature



4-2 Rated Voltage

The rated voltage shall be determined by the following expression.

 $V = \sqrt{P \times R}$

Where V: Rated voltage (V)

R: Nominal resistance value (Ω)

P: Rated dissipation (W)

4-3 Operating and Storage Temperature Range $-55 \text{ to } +125^{\circ}\text{C}$

5. Marking

A rated resistance shall be marked on the protective coat with three digit of number. Example $-0.22\Omega \rightarrow \boxed{R22}$ But, there is no marking in the rated resistance under 0.1Ω



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No	Test Item	Condition of Test	Requirements
1	Resistance and tolerance	Refer to IEC 60115-1 Sub-clause 4.5.	Not exceed the specified tolerance on rated resistant in paragraph 4-1
2	of Resistance	Resistance shall be measured under standard atmospheric conditions. When the temperature reaches and maintained at 100°C higher than the temperature of standard atmospheric conditions, resistance shall be measured again. The measurement shall be made after a period of 30 min, after each specified temperature is reached. Refer to IEC 60115-1, Sub-clause 4.13	Not exceed the temperatur tolerance coefficient of resistance in paragraph 4-
3		Place the specimen on the groove of metal plate so the edge of metal block positions almost center of both electrodes, with the surface of insulation enclosure located downward or upward and pressurize the block by a of 1.0 ± 0.2 N. The test voltage shall be 100 ± 15 V d.c., and maintain this voltage for about 1 min. The insulation resistance shall then be measured while applying the voltage.	 insulating enclosures. 100MΩ or more (2)Between electrode and ba material 1000MΩ or more
	Pressure Ro (Metal) Measurement H (R0.25mm~R0.3 Substr Over coat Fi Substrate S	Point A 5 mm) ate Im B M	sulation Plate Spring Test Sample Ietal Block ment Point B
4	Voltage Proof	The specimen shall be tested as shown in paragraph 6.1.4. The test voltage shall be a voltage of 100V voltage : $100V_{AC}$ The voltage is gradually increased at a rate of about 100 V/s. from almost o V to the specified voltage and maintained as it is for 60s.±5s, then gradually decreased to almost 0 V. Refer to IEC 60115-1.Sub-clause 4.7.	Change in resistance: ± (0.5%) Without damage by flash ov burning or breakdown etc.

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5	Substrate bending test (Bond strength of the end face plating)	Apply pressure in the direction of the. arrow at a rate of about 1mm/s.until bent width reaches 3 mm and hold for 30 s. Test PC Board Supports Solder Supports (\$\$5) Press Jig R230 Press Jig R230 Refer to IEC 60115-1 Sub-clause 4.33.	Change in resistance: ± (0.5%) Without mechanical damage such as breaks.
6	Body strength	A load of 10N (1.02kgf) using a R0.5 pressure rod shall be applied to the center in the direction of the arrow and held for 10 \pm 1 sec.	Change in resistance : ± (0.5%) Without mechanical damage such as breaks.



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7	Resistance to Soldering	(1) Solder bath method			Change in resistance : ±	
	Heat	Pre-heat : 100 to 110° C 30 sec.			(0.5%)	
		Temperature : $270 \pm 5^{\circ}$ C 10 ± 1		$\pm 5^{\circ}$ C 10 ± 1 sec.	Without mechanical	
		(2) Reflow Soldering method Peak temperature : $260 \pm 5^{\circ}$ C 10 sec or			damage.	
		less			shall be satisfied.	
	Temperature : $220 \pm 5^{\circ}$ C 60 sec					
		2 cycles or less				
	The temperat			all be surface		
			perature.			
			oldering iron me			
			Temperature : 3	$550 \pm 5^{\circ}$ C		
			he: 3 + 1/0 sec			
		-		e stored at standard		
			pheric condition	ents shall be made.		
	Refer to IEC 60115-1 Sub-clause 4.18.					
8	Solderability	Solder temperature : $245 \pm 5^{\circ}$ C		A new uniform coating of		
		Duration of immersion: 2 ± 0.5 sec		solder shall cover minimum of 95% of the surface being immersed.		
		Refer to IEC 60115-1 Sub-clause 4.17				
9	Solvent Resistance	Immersion cleaning		Without distinct damage in appearance		
		At normal temperature, 5min Isopropyl				
		alcohol				
		Refer to IEC 60115-1 Sub-clause 4.29				
10	Rapid Change of	The sp	ecimen shall be s	subjected to 5	Change in resistance : ±	
	Temperature	continuous cycles, each as shown in the		(0.5%)		
		figure below.		Without mechanical damage		
			Temperature	Time	and distinct damage.	
		1	-55±3°C	30min		
		2	RT	2~3min		
		3	+125±2°C	30min		
		4	RT	2~3min		
		Use for Testing board B. R.T.=Room Temperature				
		Refer to IEC 60115-1 Sub-clause 4.19				
		Keler to IEC 00115-1 Sub-clause 4.19				



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11	Endurance	The specimen shall be placed in the test	Change in resistance : ±
	(damp heat with load)	chamber at a temperature $60 \pm 2^{\circ}$ C and a	(1.0%)
		relative humidity 90 to 95%. And then	Without mechanical damage
		subjected to a voltage cycle consisting of	and distinct damage.
		rated d.c. voltage application of 1 hr 30min	
		and rest of 30min repeatedly for 1,000 + 48	
		/0 h.	
		However the applied voltage shall not	
		exceed the limited element voltage.	
12	Endurance	The specimen shall be placed in the test	Change in resistance : ±
		chamber at $70 \pm 2^{\circ}$ C. And then subjected to a	(1.0%)
		voltage cycle consisting of rated d.c. voltage	Without mechanical damage
		application for 1 or 30 min and rest of 30 min	and distinct damage.
		repeatedly for 1,000 $^{+48}_{0}$ h.	
		However the applied voltage shall not exceed	
		the limited element voltage.	
		Refer to IEC 60115-1 Sub-clause 4.25	



Mounting of the test sample onto the test board shall be either of following methods.

(1) Mounting by solder dipping

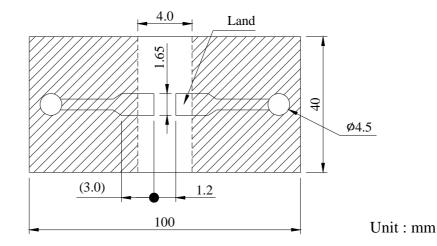
Epoxy based glue shall be applied in the middle of two lands of the test board. The resistor shall be mounted in such a way that the electrodes of resistors will be evenly placed in the land area and then adhesive resin shall be cured. After applying the Resin Flux with 25 weight % Methyl Alcohol, the board shall be soldered by dipping into a molten solder bath with $260 \pm 5^{\circ}$ C for 3 to 5 seconds

(2) Mounting by Reflow soldering

Solder paste with approximate 200 μ m thickness shall be applied to the land of test board. The resistor shall be mounted in such way that the electrodes of resistors will be evenly placed in the land area and then shall be soldered under the circumstance that the surface temperature of the board shall be raised $245 \pm 5^{\circ}$ C (peak) for 5 to 10 seconds in an upper-heater oven.

Test board A

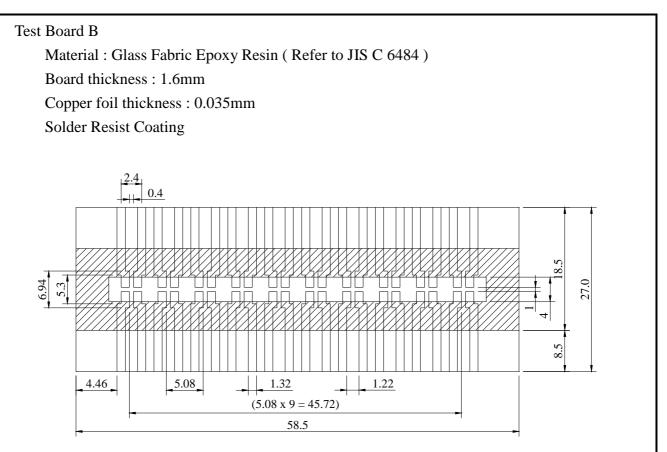
Material : Glass Fabric Epoxy Resin (Refer to JIS C 6484) Board thickness : 1.6mm Copper foil thickness : 0.035mm Solder Resist Coating



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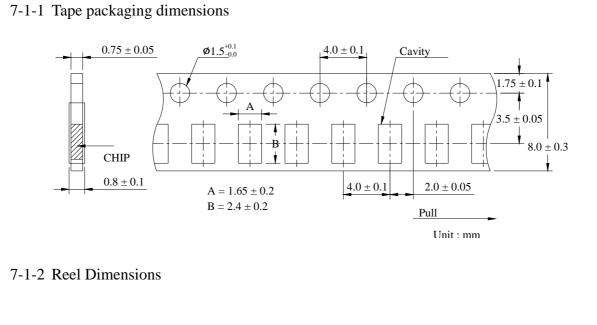
Unit : mm

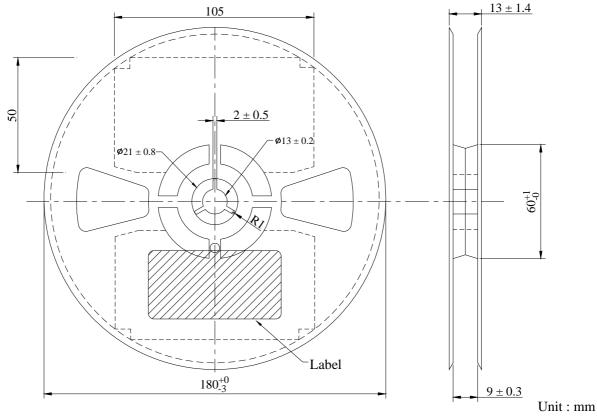


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- 7. Packaging
 - 7-1 Dimensions





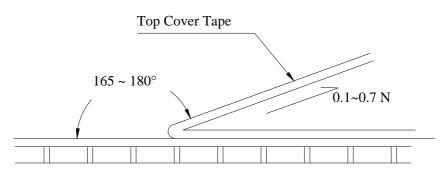
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7-2 Peel force of top cover tape

The peel speed shall be about 300 mm/min.

The peel force of top cover tape shall be between 0.1 to 0.7 N.



7-2 Numbers of taping

5,000 pieces/reel

7-3 Label marking

The following items shall be marked on single of the reel.

- (1) Type designation.
- (2) Quantity
- (3) Manufacturing date code
- (4) Manufacturer's name
- (5) The country of origin
- (6) Shipping number
- (7) Identification showing lead free products.